Overview

In a field that is advancing every day due to OS and app upgrades, attackers, and coordinated threats, forensic and incident response (IR) professionals need to be constantly learning and challenging assumptions. A single examiner may be looking into ransomware and data destruction one day and missing persons the next. Whether to support business continuity or ensure personal safety, examiners need exposure to new and novel techniques for investigating a wide variety of data sources and require vetted solutions that help find answers - fast.

Take evolutions in identification and acquisition for example. It used to be that search and seizure of electronic evidence meant grabbing everything with a disk or chip. Today a full picture of user activity might rest in the cloud, so how can examiners identify and obtain this information? Not only that, but how do they pull in data from remote systems alongside more traditional sources in their tools to be able to tell a complete story?

Examiners today are aware that no single tool will fulfill all of their digital forensic and incident response (DFIR) collection, analysis, and reporting needs. Examiners need to understand the best solutions for day-to-day work and when to employ specialist tools to paint an accurate picture of activity when writing reports.

Join this SANS lead forum as we explore various DFIR & IR topics through invited speakers while showcasing current capabilities available today. Presentations will focus on technical case-studies and thought leadership using specific examples relevant to the industry.

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